



IEC 61850 Certificate Level A¹

Page 1/2 No. 21-021893-01-1

Issued to: GENAD SYSTEM Co.,Ltd. 78, Hyeoksinsandan 5-gil, Naju-si, Jeollanam-do, Republic of Korea For the server product:
High-Voltage Direct Current-Intelligent
Electronic Device; HVDC-IED
HVDC-IED
Software Version 1.0

HW: HD-IED OS: Linaro14.04 S/N: 20210429

Issued by: Korea Testing Laboratory

The server product has not been shown to be non-conforming to: IEC 61850 Edition 2 Parts 6, 7-1, 7-2, 7-3, 7-4 and 8-1 Communication networks and systems for power utility automation

The conformance test has been performed according to IEC 61850-10 Edition 2, the UCA International Users Group Edition 2 Server Test Procedures version 2.0.4 with product's protocol, model and technical issue implementation conformance statements: "HVDC-IED_PICS_v1.0", "HVDC-IED_MICS_v1.0", "HVDC-IED_TICS_v1.0" and product's extra information for testing: "HVDC-IED_PIXIT_v2.0".

The following IEC 61850 conformance blocks have been tested with a positive result (number of relevant and executed test cases / total number of test):

1	Basic Exchange (19/26)	6	Buffered Reporting (29/33)
2	Data Sets (4/7)	13	Time Synchronization (4/7)
2+	Data Set Definition (24/24)	14	File Transfer (5/8)

This Certificate includes a summary of the test results as carried out at Korea Testing Laboratory in Republic of Korea with IEC 61850 Ed2 KTL Testing Tool 1.0 with test suite IEC 61850 Ed2 Server Conformance Test V.1.0 and IEC 61850 Ed2 KTL Trace Manager V.1.0. This document has been issued for information purposes only, and the original paper copy of the KTL report: No. TR-21-021893-01-1 will prevail.

The test has been carried out on one single specimen of the product as referred above and submitted to KTL by GENAD SYSTEM Co.,Ltd.. The manufacturer's production process has not been assessed. This certificate does not imply that KTL has certified or approved any product other than the specimen tested.

Seoul, Jun. 9, 2021

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1 Level A - Independent Test lab with accredited ISO/IEC 17025 Quality System





Page 2/2

Applicable Test Procedures from the UCA International Users Group Server Device Test Procedures version 2.0.4

Conformance Block	Mandatory	Conditional
1: Basic Exchange	sAss1, sAss2, sAss3, sAss4, sAssN2, sAssN3, sAssN4, sAssN5, sSrv1, sSrv2, sSrv3, sSrv4, sSrv5, sSrv8, sSrvN1abcdf, sSrvN4	sAssN6, sSrv6, sSrvN1e
2: Data Sets	sDs1, sDs10a, sDsN1ae	sDs15
2+: Data Set Definition	sDs2, sDs3, sDs4, sDs5, sDs6, sDs7, sDs8, sDs9, sDs13, sDs14, sDsN1cd sDsN2, sDsN3, sDsN4, sDsN5, sDsN6, sDsN7, sDsN8, sDsN9, sDsN10	sDs11, sDs12, sDsN11, sDsN12
6: Buffered Reporting	sBr1, sBr2, sBr3, sBr4, sBr5, sBr9, sBr14, sBr16, sBr20, sBr21. sBr22, sBr25, sBr26, sBr27, sBr28, sBr29, sBrN1, sBrN2, sBrN3, sBrN4, sBrN5, sBrN8	
13 Time sync	sTm1, sTm2, sTmN1	sTmN2
14 File transfer	sFt1, sFt2ab, sFt4, sFt5, sFtN1ab	